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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/757,073	YEH ET AL.	
Examiner	Art Unit	
Tan T. Nguyen	2827	_

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	185.19	11/22/2005	TNT
365	185.22	11/22/2005	TNT
365	185.28	11/22/2005	TNT
365/1	85.29	11/22/2005	TNT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
365/185.19, 185.22, 185.28, 185.29 (text search only - see search history printout)	11/22/2005	TNT
PGPUB Text Search (see interference search printout)	11/22/2005	TNT
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